

PRODUCT CATALOG

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SPECTRODENSITOMETER





SPECTRODENSITOMETER

Spectrodensitometer has the capability of densitometer and measures color and numeric color differences and widely used in the ink printing

1300 SPECTRODENSITOMETER

45/0 geometrical optics structure, comply with CIE, the testing conditions of M O, M 1, M 2, M 3 stipulated by ISO 13655 standard, it can accurately measure various printing density, overprint rate and other printing parameters.

Accurately measure reflectance spectrum, CMYK density and Lab value of the sample;

High-configuration electronic hardware: 3.5-inch TFT true-color screen, capacitive touch screen, concave grating, 256-pixel dual-array CMOS image sensor, etc.;

Perfect combination of the beautiful appearance and the ergonomic structure design;

Optional apertures: Φ 2/4/8mm, adapt to more samples;

Large-capacity storage space, over 20,000 test data

Combined LED light sources with long life and low power consumption, including UV light;

USB/Blue2.1 dual communication mode is widely useful;

Especially suitable for process control and quality control of printing plants;

PC software has powerful function expansion.

SPECIFICATIONS

Model	BSDM-1301	BSDM-1302	BSDM-1303	BSDM-1304		
Optical Geometry	45/0(45 ring-shaped illumination, 0 degree viewing angle)					
Standards compliant	ISO 5-4,CIE No.15 Compliance with ISO 13655 measurement conditions; M0 (CIE Light Soure A) M1 (CIE Light Soure D50) M2 (Excluding UV light source) M3 (M2+Polarized light filter)					
Illuminant	D65,A,C,D50,D55,D65,D75,F2(CWF),F7(DLP),F11(TL	84),F12(TL83/U30),F1,F3,F4,F5,F6,F8,F9,F10(TPL5)	D65, A,C,D50,D55,D65,D75,F2,F7,F11,F12			
Spectral Mode	Concave Grating					
Sensor	256 Image Element Double Array CMOS Image Sensor					
Wavelength Pitch	10 nm					
Semi-bandwidth	10 nm					
Density Standards	ISO Status A, E, I, T					
Density index	contrast, tone error and gray scale, density scanning	rgement, overprint, printing characteristics, printing g Customized one aperture: Φ2mm,Φ4mm,Φ8mm onal	Density value, de dot area, dot enlar printing charact contrast, tone en Customi aperture: Ф2m opti	gement, overprint, eristics, printing ror and gray level ized one m,Φ4mm,Φ8mm		
color space	CIE LAB,XYZ,Yxy,LCI	n,CIE LUV,HunterLAB	CIE LAB,XYZ,Yxy,Lch			
Color Difference Formula	ΔΕ*ab,ΔΕ*94,ΔΕ*00,ΔΕ*uv,ΔΕ*α	:mc(2:1),ΔE*cmc(1:1),ΔE(Hunter)	ΔΕ*αb,ΔΕ*94,ΔΕ*00			
Other Colorimetric data	WI(ASTM E313,CIE/ISO,AATCC,Hunter), YI(ASTM E	01925,ASTM 313), MI (Metamerism Index),Opacity	/			
Observer	2° / 10°					
Measurement Time	About 1.5s					
Repeatability		n Δ E*ab 0.03 (When a white calibration plate is intervals after white calibration)	value:within ∆E* white calibration	plate is measured and intervals after		

Inter-instrument agreement	Within ∆E*ab 0.18 (Average for 12 BCRA Series II color tiles)	Within ∆E*ab 0.2 (Average for 12 BCRA Series II color tiles)	
Measurement Method	Single Measurement, Average Measurement(2-99)		
Interface	USB, Bluetooth	USB	



Biolab Scientific Ltd.

3660 Midland Avenue, Suite 300, Toronto, Ontario M1V 0B8, Canada Email: contact@biolabscientific.com | Website: www.biolabscientific.com